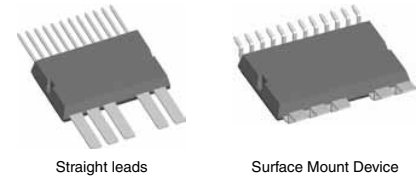
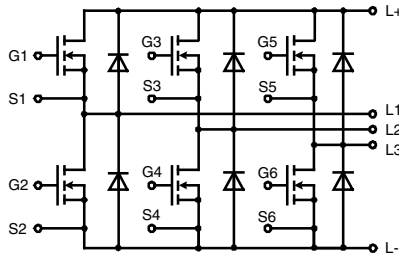


Three phase full Bridge with Trench MOSFETs in DCB isolated high current package

$V_{DSS} = 75 \text{ V}$
 $I_{D25} = 110 \text{ A}$
 $R_{DSon \text{ typ.}} = 4.0 \text{ m}\Omega$



| MOSFETs | | | |
|-----------|---|-----------------|---|
| Symbol | Conditions | Maximum Ratings | |
| V_{DSS} | $T_{VJ} = 25^\circ\text{C to } 150^\circ\text{C}$ | 75 | V |
| V_{GS} | | ± 20 | V |
| I_{D25} | $T_C = 25^\circ\text{C}$ | 110 | A |
| I_{D90} | $T_C = 90^\circ\text{C}$ | 85 | A |
| I_{F25} | $T_C = 25^\circ\text{C}$ (diode) | 110 | A |
| I_{F90} | $T_C = 90^\circ\text{C}$ (diode) | 80 | A |

Applications

- AC drives
 - in automobiles
 - electric power steering
 - starter generator
 - in industrial vehicles
 - propulsion drives
 - fork lift drives
- in battery supplied equipment

Features

- MOSFETs in trench technology:
 - low R_{DSon}
 - optimized intrinsic reverse diode
- package:
 - high level of integration
 - high current capability 300 A max.
 - aux. terminals for MOSFET control
 - terminals for soldering or welding connections
 - isolated DCB ceramic base plate with optimized heat transfer
- Space and weight savings

| Symbol | Conditions | Characteristic Values | | | | |
|--------------|---|---|------|------|---------------------|------------|
| | | $(T_{VJ} = 25^\circ\text{C}, \text{ unless otherwise specified})$ | | | | |
| | | min. | typ. | max. | | |
| R_{DSon} | on chip level at $V_{GS} = 10 \text{ V}; I_D = 60 \text{ A}$ | $T_{VJ} = 25^\circ\text{C}$ | | 4.0 | 4.9 | m Ω |
| | | $T_{VJ} = 125^\circ\text{C}$ | | 7.2 | 8.4 | m Ω |
| $V_{GS(th)}$ | $V_{DS} = 20 \text{ V}; I_D = 1 \text{ mA}$ | 2 | | 4 | V | |
| I_{DSS} | $V_{DS} = V_{DSS}; V_{GS} = 0 \text{ V}$ | | 0.1 | 1 | μA mA | |
| I_{GSS} | $V_{GS} = \pm 20 \text{ V}; V_{DS} = 0 \text{ V}$ | | | 0.2 | μA | |
| Q_g | $V_{GS} = 10 \text{ V}; V_{DS} = 36 \text{ V}; I_D = 25 \text{ A}$ | | 115 | | nC | |
| Q_{gs} | | | 30 | | nC | |
| Q_{gd} | | | 30 | | nC | |
| $t_{d(on)}$ | $V_{GS} = 10 \text{ V}; V_{DS} = 30 \text{ V}$ $I_D = 80 \text{ A}; R_G = 39 \Omega$ inductive load $T_{VJ} = 125^\circ\text{C}$ | | 130 | | ns | |
| t_r | | | 100 | | ns | |
| $t_{d(off)}$ | | | 500 | | ns | |
| t_f | | | 100 | | ns | |
| E_{on} | | | 0.20 | | mJ | |
| E_{off} | | 0.50 | | mJ | | |
| E_{recoff} | | 0.01 | | mJ | | |
| R_{thJC} | with heat transfer paste (IXYS test setup) | | | 1.0 | K/W | |
| R_{thJH} | | | 1.3 | 1.6 | K/W | |

Package options

- 2 lead forms available
 - straight leads (SL)
 - SMD lead version (SMD)

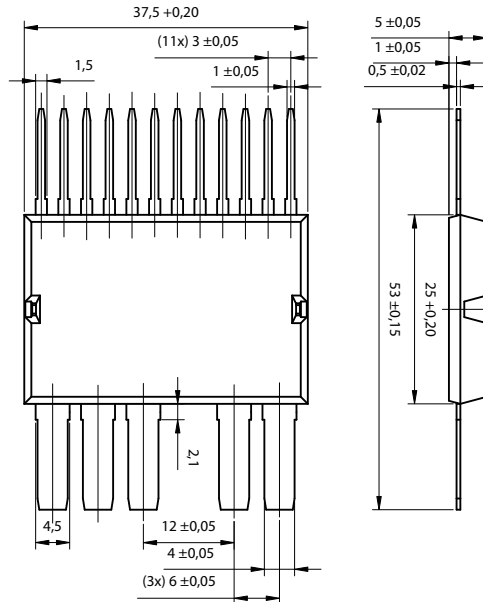
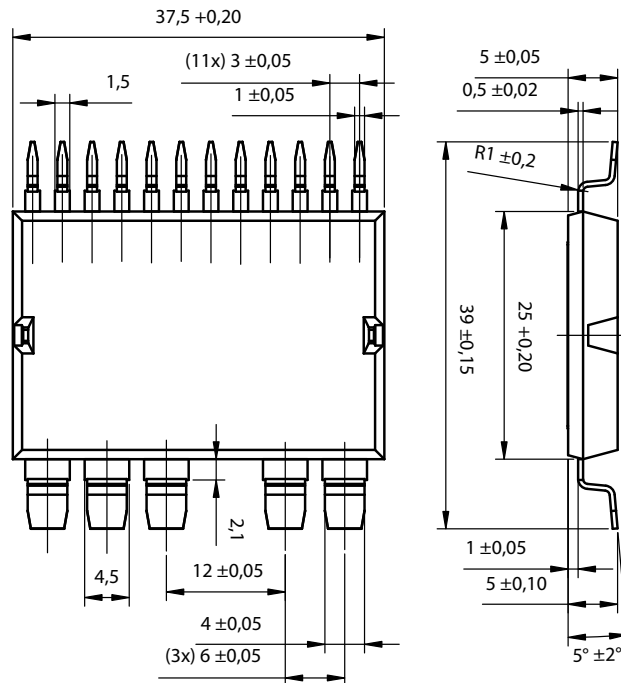
Source-Drain Diode

| Symbol | Conditions | Characteristic Values | | | |
|--|--|-----------------------|------|------|---------------|
| | | min. | typ. | max. | |
| ($T_J = 25^\circ\text{C}$, unless otherwise specified) | | | | | |
| V_{SD} | (diode) $I_F = 80\text{ A}$; $V_{GS} = 0\text{ V}$ | | 0.9 | 1.2 | V |
| t_{rr} | $I_F = 80\text{ A}$; $-di_F/dt = 800\text{ A}/\mu\text{s}$ $V_R = 30\text{ V}$; $T_J = 125^\circ\text{C}$ | | 55 | | ns |
| Q_{RM} | | | 0.9 | | μC |
| I_{RM} | | | 30 | | A |

Component

| Symbol | Conditions | Maximum Ratings | |
|------------|---|-----------------|------------------|
| | | | |
| I_{RMS} | per pin in main current paths (P+, N-, L1, L2, L3) may be additionally limited by external connections | 300 | A |
| T_{VJ} | | -55...+175 | $^\circ\text{C}$ |
| T_{stg} | | -55...+125 | $^\circ\text{C}$ |
| V_{ISOL} | $I_{ISOL} \leq 1\text{ mA}$, 50/60 Hz, $f = 1\text{ minute}$ | 1000 | V~ |
| F_C | mounting force with clip | 50 - 250 | N |

| Symbol | Conditions | Characteristic Values | | |
|---------------------|---|-----------------------|------|------------------|
| | | min. | typ. | max. |
| $R_{pin\ to\ chip}$ | with heatsink compound | | 0.6 | $\text{m}\Omega$ |
| C_P | coupling capacity between shorted pins and mounting tab in the case | | 160 | pF |
| Weight | typ. | | 25 | g |

Straight Leads GWM 120-0075X1-SL

Surface Mount Device GWM 120-0075X1-SMD


| Leads | Ordering | Part Name & Packing Unit Marking | Part Marking | Delivering Mode | Base Qty. | Ordering Code |
|----------|----------|----------------------------------|----------------|-----------------|-----------|---------------|
| Straight | Standard | GWM 120-0075X1 - SL | GWM 120-0075X1 | Blister | 28 | 505 960 |
| SMD | Standard | GWM 120-0075X1 - SMD | GWM 120-0075X1 | Blister | 28 | 505 581 |

IXYS reserves the right to change limits, test conditions and dimensions.

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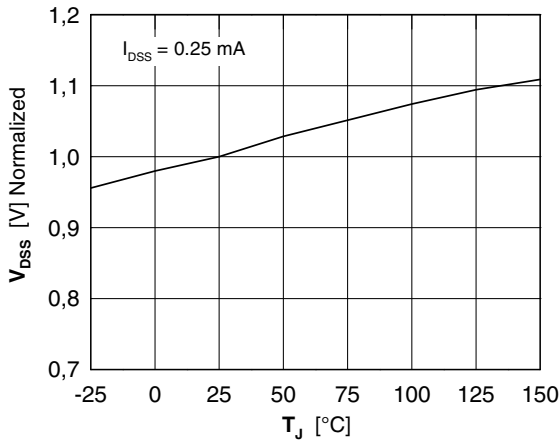


Fig. 1 Drain source breakdown voltage V_{DSS} vs. junction temperature T_J

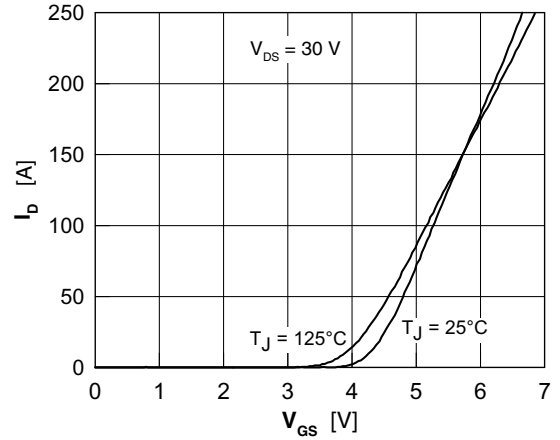


Fig. 2 Typical transfer characteristic

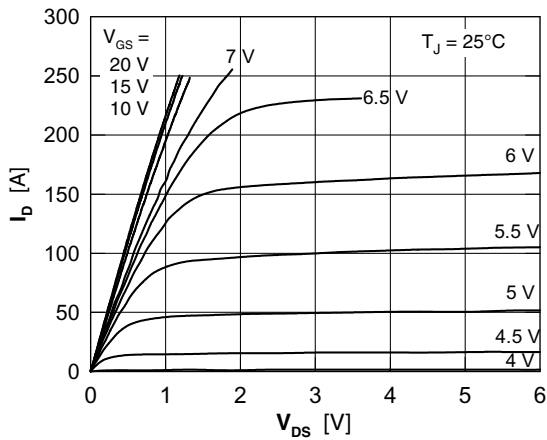


Fig. 3 Typical output characteristic

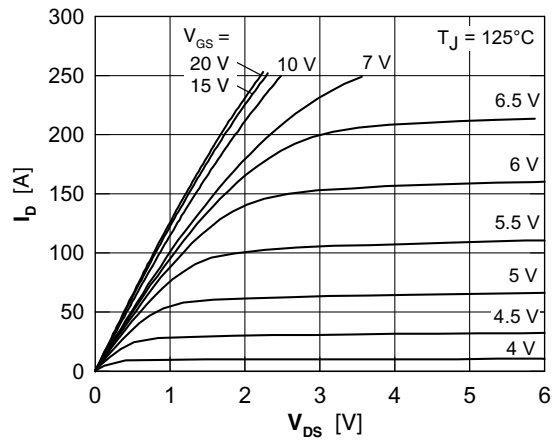


Fig. 4 Typical output characteristic

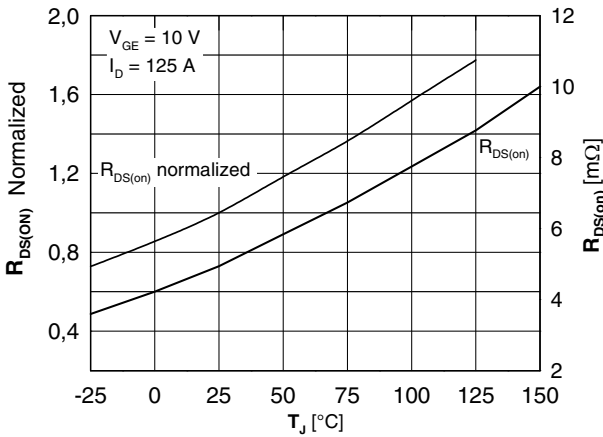


Fig. 5 Drain source on-state resistance $R_{DS(on)}$ versus junction temperature T_J

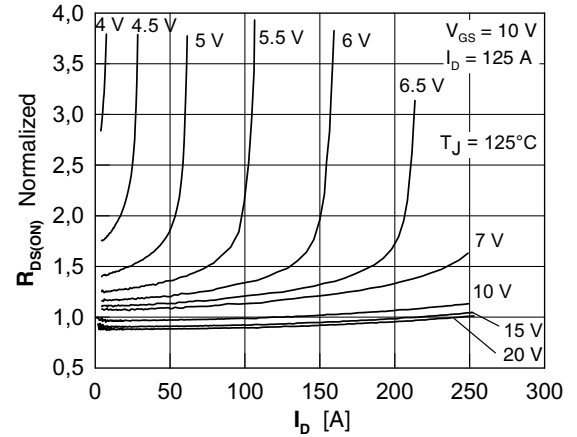


Fig. 6 Drain source on-state resistance $R_{DS(on)}$ versus I_D

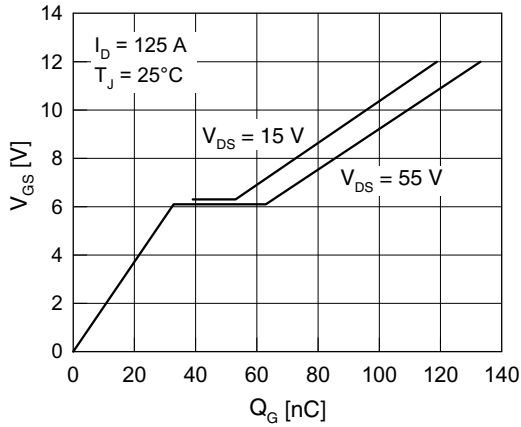


Fig. 7 Gate charge characteristic

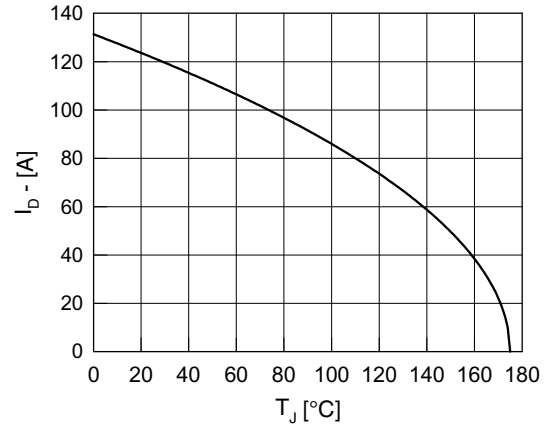
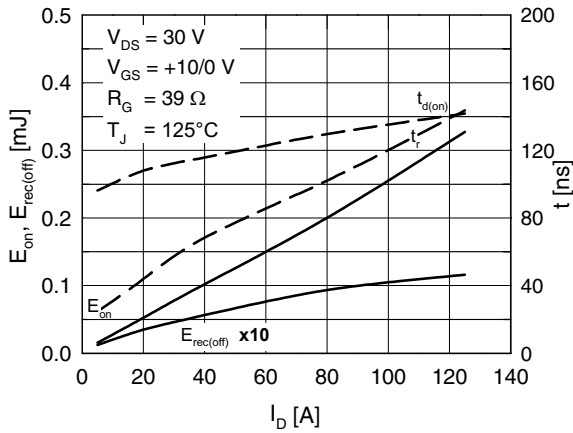

 Fig. 8 Drain current I_D vs. case temperature T_C


Fig. 9 Typ. turn-on energy & switching times vs. collector current, inductive switching

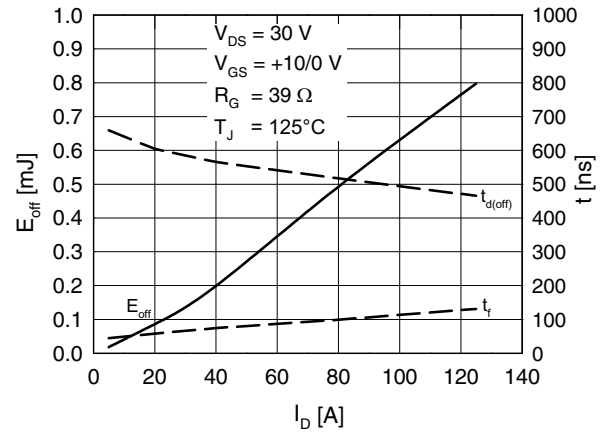


Fig. 10 Typ. turn-off energy & switching times vs. collector current, inductive switching

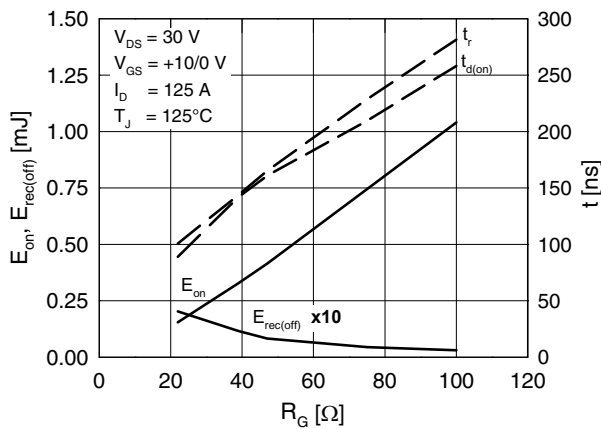


Fig. 11 Typ. turn-on energy & switching times vs. gate resistor, inductive switching

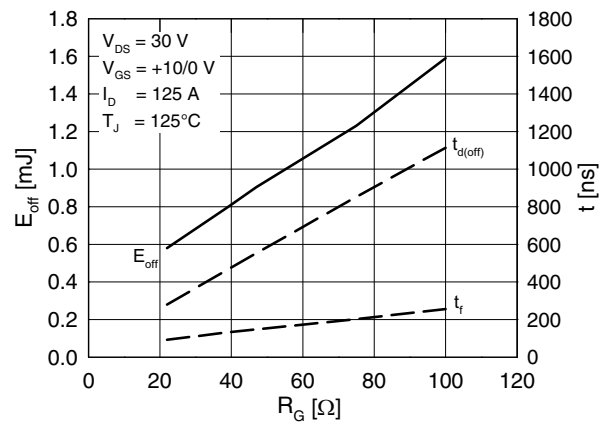


Fig. 12 Typ. turn-off energy & switching times vs. gate resistor, inductive switching

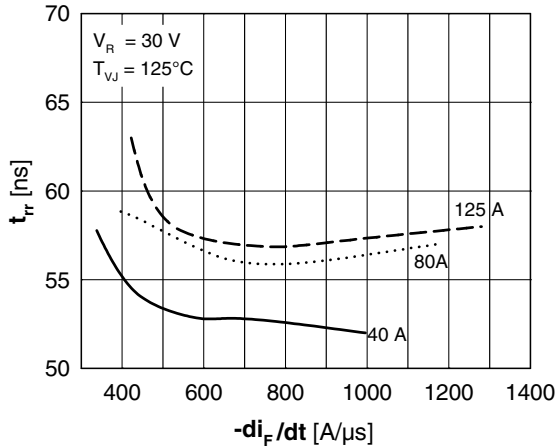


Fig. 13 Reverse recovery time t_{rr} of the body diode vs. di/dt

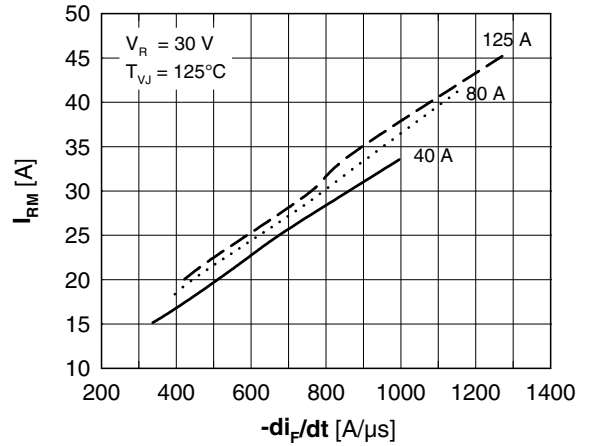


Fig. 14 Reverse recovery current I_{RM} of the body diode vs. di/dt

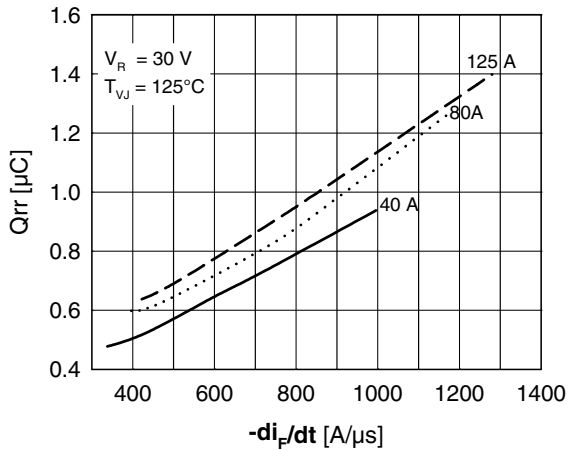


Fig. 15 Reverse recovery charge Q_{rr} of the body diode vs. di/dt

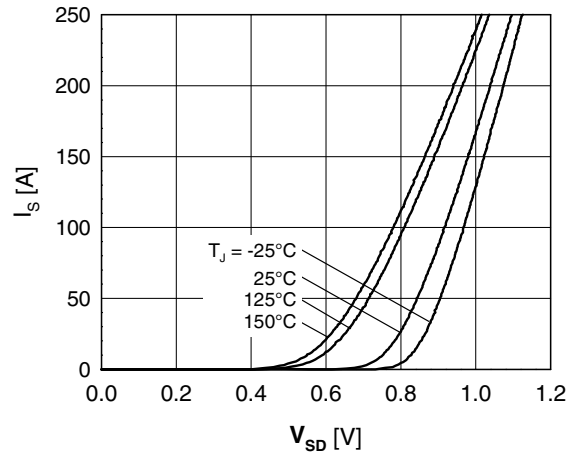


Fig. 16 Source current I_s vs. source drain voltage V_{SD} (body diode)

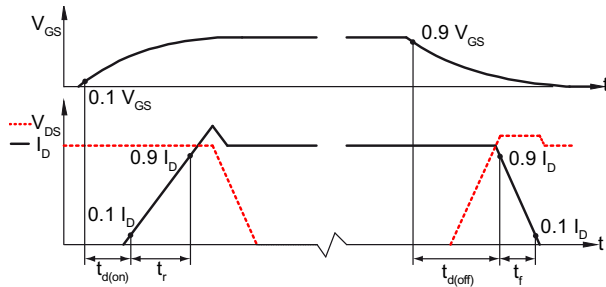


Fig. 17 Definition of switching times

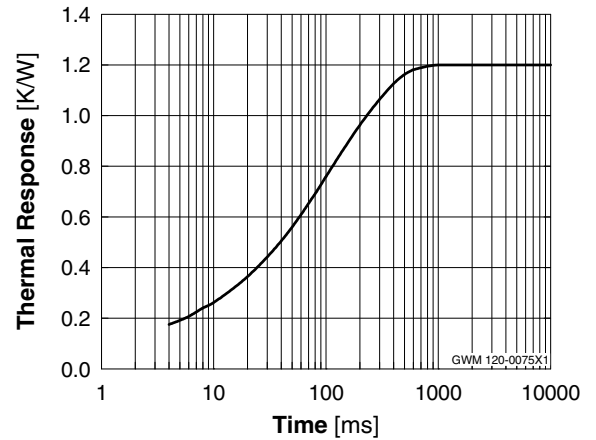


Fig. 18 Typ. therm. impedance junction to heatsink Z_{thJC}